Search Notes



Application/Control No.	Applicant(s)/Patent und Reexamination	
10/625,893	PHU, THINH N	GUYEN
Examiner	Art Unit	
Meless N. Zewdu	2617	

SEARCHED			
Class	Subclass	Date	Examiner
455	456.1- 456.6	1/3/2006	M.Z.
455	433-434	1/3/2006	M.Z.
455	436-451	1/3/2006	M.Z.
455	452.1	1/3/2006	M.Z.
455	452.2	1/3/2006	M.Z.
455	453, 466	1/3/2006	M.Z.
455	403, 458	1/3/2006	M.Z.
455	550.1	1/3/2006	M.Z.
455	560-561	1/3/2006	M.Z.
455	422.1	1/3/2006	M.Z.
455	432.1	1/3/2006	M.Z.
455	432.2	1/3/2006	M.Z.
455	432.3	1/3/2006	M.Z.
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Subclass	Date	Examiner
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Search Notes (continued)



Application/Control No.

Applicant(s)/Patent under Reexamination

10/625,893

PHU, THINH NGUYEN

Examiner

Art Unit

Meless N. Zewdu

2617

SEARCHED			
Class	Subclass	Date	Examiner
370	395.52- 395.53	1/3/2006	M.Z.
370	395.5	1/3/2006	M.Z.
370	386, 389	1/3/2006	M.Z.
370	360, 363	1/3/2006	M.Z.
370	349, 463	1/3/2006	M.Z.
370	352-353	1/3/2006	M.Z.
370	337-339	1/3/2006	M.Z.
370	331-333	1/3/2006	M.Z.
370	328-329	1/3/2006	M.Z.
370	311-313	1/3/2006	M.Z.
709	206, 218	1/3/2006	M.Z.
709	226	1/3/2006	M.Z.
709	228-229	1/3/2006	· M.Z.
455	424-425	1/3/2006	M.Z.

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Searched in EAST (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT & IBM_TDB)	12/27/2006	M.Z.
Search by inventor	12/27/2006	M.Z.
Additional text search in WEST	12/29/2006	M.Z.
For details, ples see attached search history print out.	1/3/2006	M.Z.
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